Vincotech

10-FY07HVA075S5-L985F08
10-PY07HVA075S5-L985F08Y
datasheet

flow **PACK 1 H6.5** **650 V / 75 A**

Features

- Innovative H6.5 Topology
- IGBT S5 + IGBT L5
- NTC

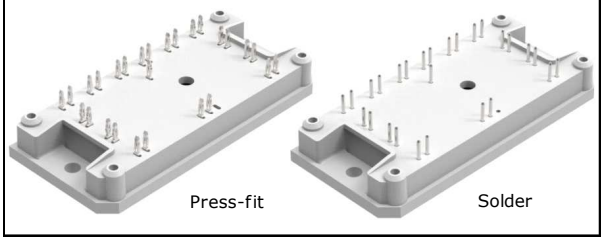
Target applications

- Solar Inverters
- Special Application

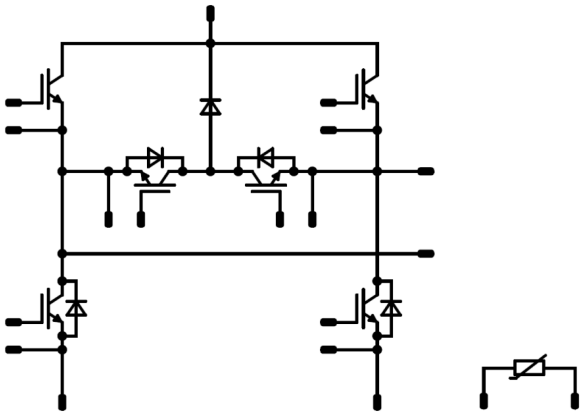
Types

- 10-FY07HVA075S5-L985F08
- 10-PY07HVA075S5-L985F08Y

flow 1 12 mm housing



Schematic



Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
High Buck Switch / Low Buck Switch				
Collector-emitter voltage	V_{CES}		650	V
Collector current	I_C	$T_j = T_{jmax}$ T_s = 80 °C	58	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	225	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	86	W
Gate-emitter voltage	V_{GES}		±20	V
Maximum junction temperature	T_{jmax}		175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Buck Diode				
Peak repetitive reverse voltage	V_{RRM}		650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ T_s = 80 °C	53	A
Repetitive peak forward current	I_{FRM}		100	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	76	W
Maximum junction temperature	T_{jmax}		175	°C
Boost Switch				
Collector-emitter voltage	V_{CES}		650	V
Collector current	I_C	$T_j = T_{jmax}$ T_s = 80 °C	85	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	225	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	95	W
Gate-emitter voltage	V_{GES}		±20	V
Maximum junction temperature	T_{jmax}		175	°C
Low Boost Diode / High Boost Diode				
Peak repetitive reverse voltage	V_{RRM}		650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ T_s = 80 °C	53	A
Repetitive peak forward current	I_{FRM}		100	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	76	W
Maximum junction temperature	T_{jmax}		175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Module Properties				
Thermal Properties				
Storage temperature	T_{stg}		-40…+125	°C
Operation temperature under switching condition	T_{jop}		-40…(T_{jmax} - 25)	°C
Isolation Properties				
Isolation voltage	V_{isol}	DC Test Voltage* t_p = 2 s	6000	V
		AC Voltage t_p = 1 min	2500	V
Creepage distance			min. 12,7	mm
Clearance		Solder	7,99	mm
		Press-fit	8,3	mm
Comparative Tracking Index	CTI		> 200	

*100 % tested in production

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
High Buck Switch / Low Buck Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	V_{GE} = V_{CE}			0,00075	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25 125 150		1,56 1,56 1,59	1,75	V
Collector-emitter cut-off current	I_{CES}		0	650		25			50	µA
Gate-emitter leakage current	I_{GES}		20	0		25			100	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 Mhz	0	25		25		4500		pF
Output capacitance	C_{oes}							130		
Reverse transfer capacitance	C_{res}							17		
Gate charge	Q_g		15	520	75	25		164		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						1,10		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	±15	350	75	25 125 150		123 121 120		ns
Rise time	t_r					25 125 150		9 8 8		
Turn-off delay time	$t_{d(off)}$					25 125 150		189 215 221		
Fall time	t_f					25 125 150		53 217 257		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,1 µC Q_{rFWD} = 3,8 µC Q_{rFWD} = 4,4 µC				25 125 150		0,171 0,164 0,200		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		3,189 4,647 5,023		

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Buck Diode										
Static										
Forward voltage	V_F				50	25 125		1,50 1,44	1,77	V
Reverse leakage current	I_R			650		25			2,65	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						1,26		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt = 7349 A/µs di/dt = 6426 A/µs di/dt = 7461 A/µs	±15	350	75	25 125 150		76 101 105		A
Reverse recovery time	t_{rr}					25 125 150		58 89 101		ns
Recovered charge	Q_r					25 125 150		2,102 3,817 4,395		µC
Reverse recovered energy	E_{rec}					25 125 150		0,623 0,986 1,148		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		4813 3089 2758		A/µs

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,001	25	4,2	5	5,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25		1,10	1,45	V
Collector-emitter cut-off current	I_{CES}		0	650		25			40	µA
Gate-emitter leakage current	I_{GES}		20	0		25			100	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 MHz	0	25		25		11625		pF
Reverse transfer capacitance	C_{res}							30		
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						1,00		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	-5/15	350	76	25 125 150		31 31 31		ns
Rise time	t_r					25 125 150		10 10 11		
Turn-off delay time	$t_{d(off)}$					25 125 150		110 126 132		
Fall time	t_f					25 125 150		10 25 32		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,2 µC Q_{rFWD} = 4 µC Q_{rFWD} = 4,7 µC				25 125 150		0,450 0,701 0,758		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,457 0,875 1,023		

Characteristic Values

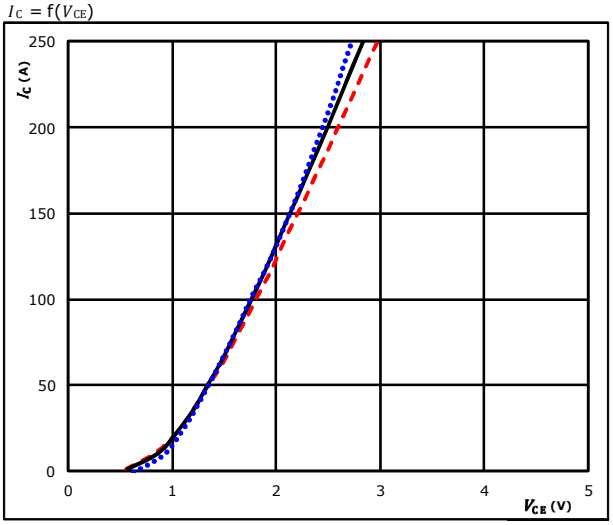
Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Low Boost Diode / High Boost Diode										
Static										
Forward voltage	V_F				50	25 125		1,50 1,44	1,77	V
Reverse leakage current	I_R			650		25			2,65	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						1,26		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt = 5329 A/µs di/dt = 8023 A/µs di/dt = 7260 A/µs	-5/15	350	76	25 125 150		86 110 117		A
Reverse recovery time	t_{rr}					25 125 150		55 87 101		ns
Recovered charge	Q_r					25 125 150		2,178 4,039 4,699		µC
Reverse recovered energy	E_{rec}					25 125 150		0,381 0,839 1,021		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		5984 4040 4174		A/µs
Thermistor										
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1484 Ω				100	-5		5	%
Power dissipation	P					25		5		mW
Power dissipation constant						25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %				25		3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %				25		4000		K
Vincotech NTC Reference									I	

High Buck Switch / Low Buck Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

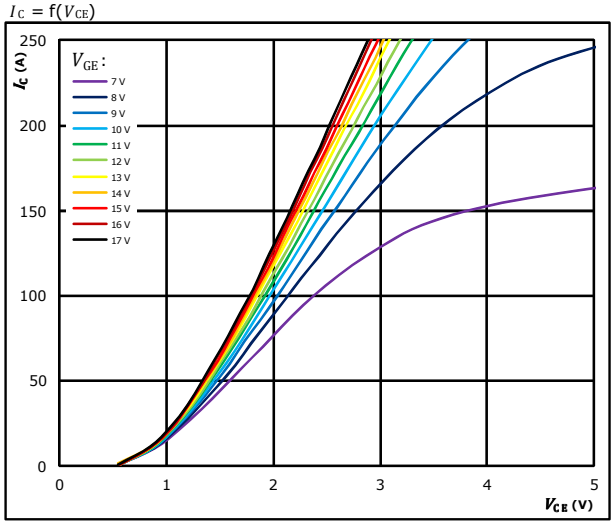


t_p =	250	µs		25 °C
V_{GE} =	15	V	T_j:	125 °C
				150 °C

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

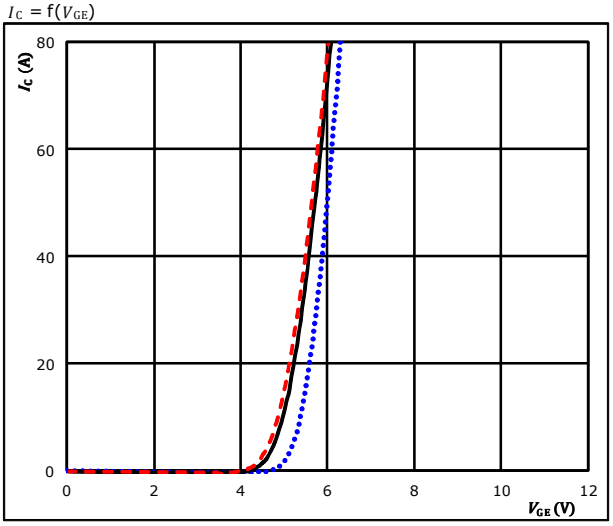


t_p =	250	µs
T_j =	150	°C
V_{GE} from	7 V to 17 V in steps of 1 V	

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

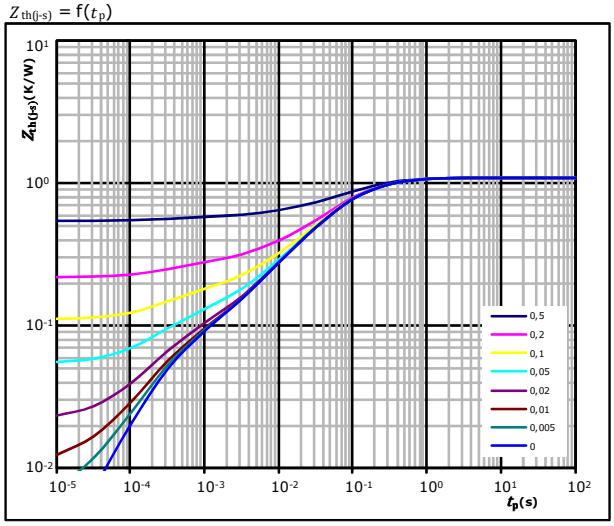


t_p =	100	µs		25 °C
V_{CE} =	10	V	T_j:	125 °C
				150 °C

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j-s)} = f(t_p)$



D =	t_p / T	
$R_{th(j-s)}$ =	1,10	K/W

IGBT thermal model values

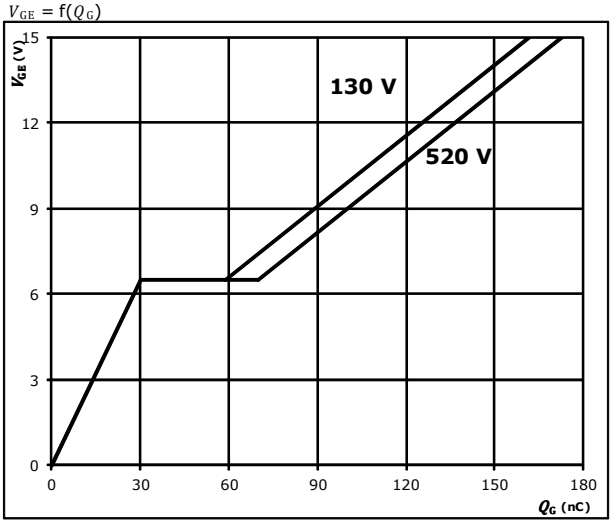
R (K/W)	τ (s)
2,16E-01	4,05E-01
6,30E-01	6,87E-02
1,62E-01	1,13E-02
3,68E-02	2,51E-03
6,02E-02	3,09E-04

High Buck Switch / Low Buck Switch Characteristics

figure 5. **IGBT**

Gate voltage vs gate charge

$V_{GE} = f(Q_G)$

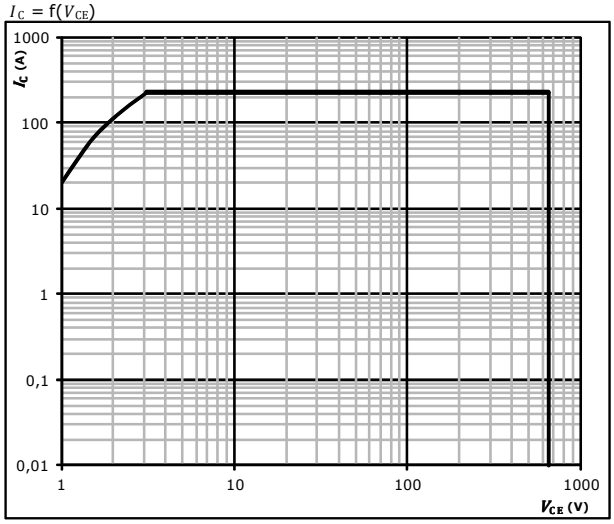


I_C= 75 A

figure 6. **IGBT**

Safe operating area

$I_C = f(V_{CE})$



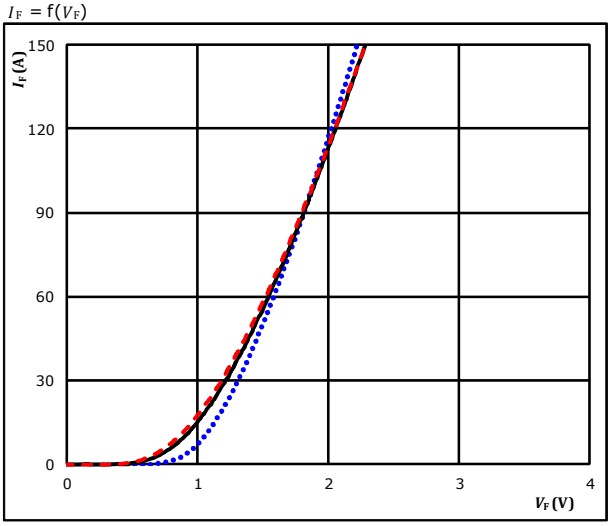
D = single pulse
T_s = 80 °C
V_{GE} = ±15 V
T_j = T_{jmax}

Buck Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



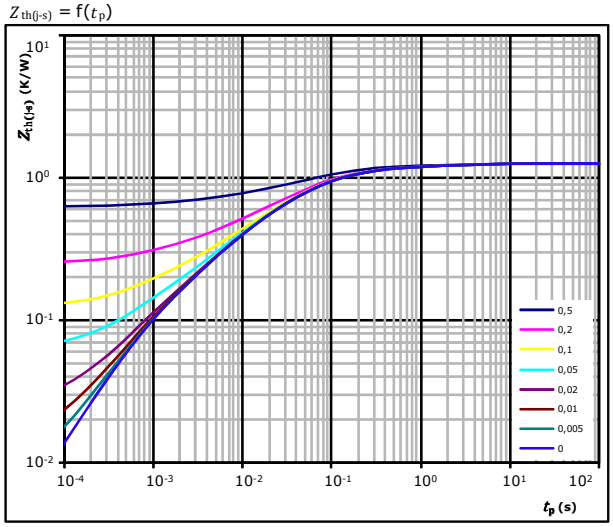
t_p = 250 µs

T_j: 25 °C
125 °C
150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



D = t_p / T

$R_{th(j-s)}$ = 1,26 K/W

FWD thermal model values

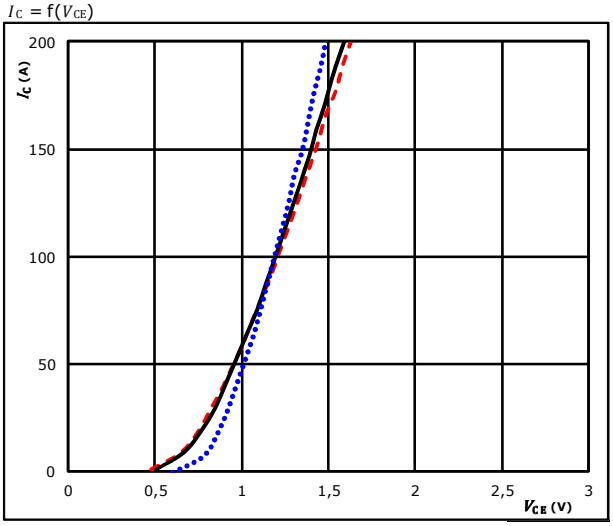
R (K/W)	τ (s)
7,02E-02	3,35E+00
1,23E-01	4,61E-01
4,54E-01	8,36E-02
3,54E-01	2,44E-02
1,81E-01	5,52E-03
7,18E-02	8,18E-04

Boost Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

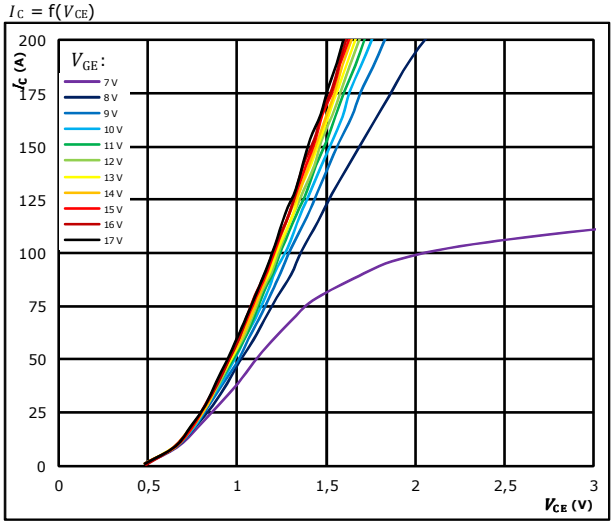


t_p =	250	µs		25 °C	
V_{GE} =	15	V	T_j:	125 °C	
				150 °C	

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

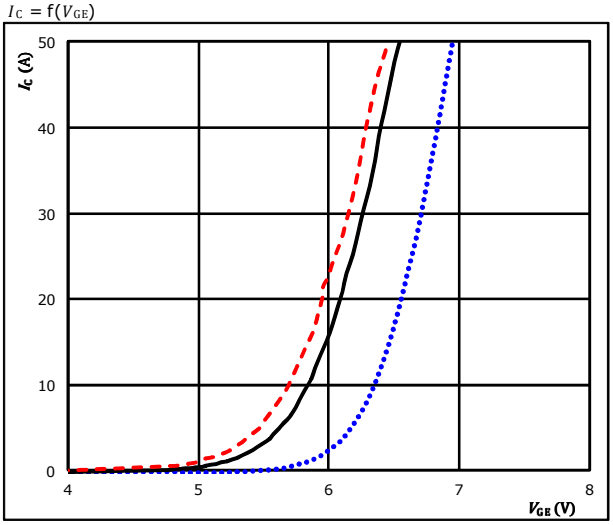


t_p =	250	µs
T_j =	150	°C
V_{GE} from	7 V to 17 V in steps of 1 V	

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

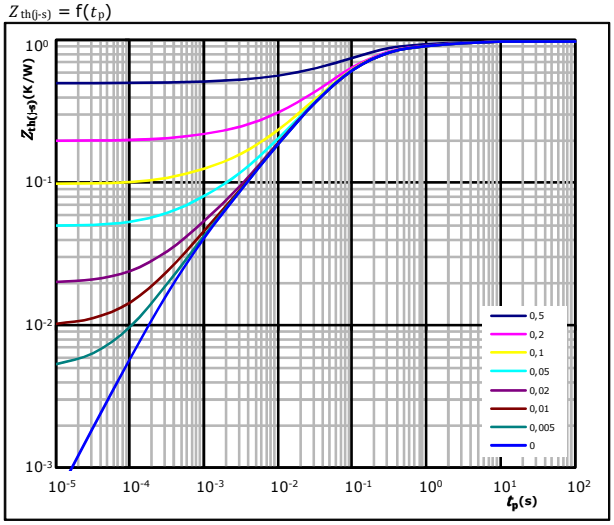


t_p =	100	µs		25 °C	
V_{CE} =	10	V	T_j:	125 °C	
				150 °C	

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j-s)} = f(t_p)$



D =	t_p / T	
$R_{th(j-s)}$ =	1,00	K/W

IGBT thermal model values

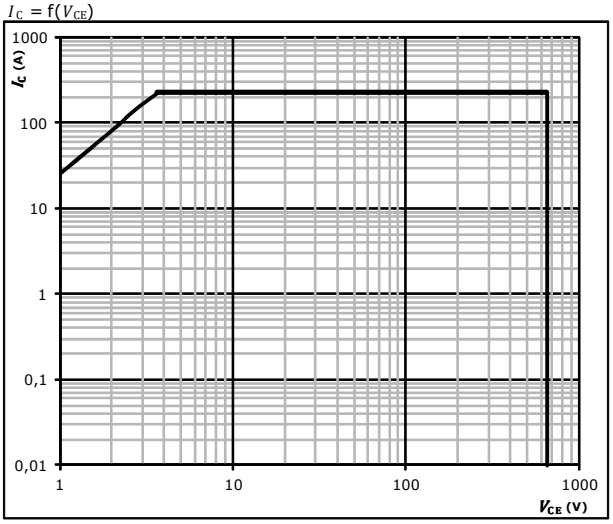
R (K/W)	τ (s)
8,80E-02	2,68E+00
1,67E-01	3,70E-01
5,38E-01	8,09E-02
1,47E-01	1,56E-02
3,80E-02	3,42E-03
1,88E-02	5,45E-04

Boost Switch Characteristics

figure 5. **IGBT**

Safe operating area

$I_C = f(V_{CE})$



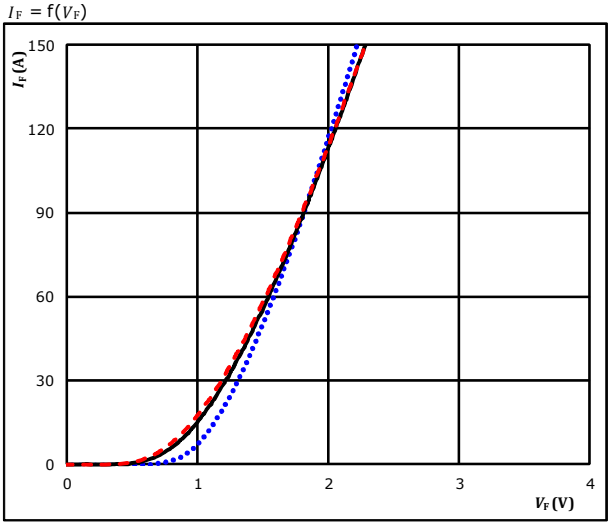
D =	single pulse	
T_s =	80	ºC
V_{GE} =	±15	V
T_j =	T_{jmax}	

Low Boost Diode / High Boost Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



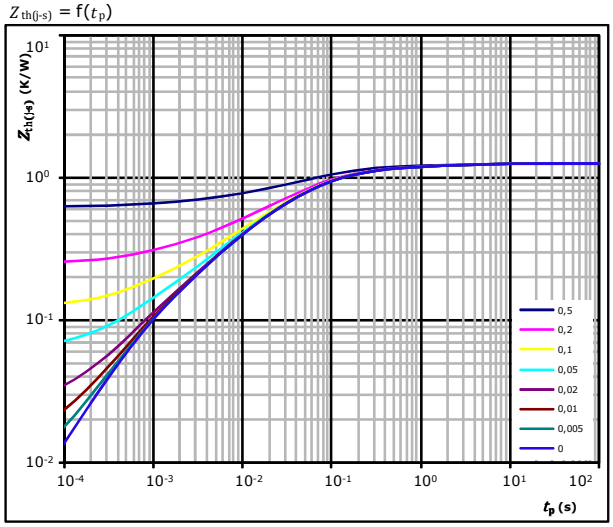
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,26 K/W

FWD thermal model values

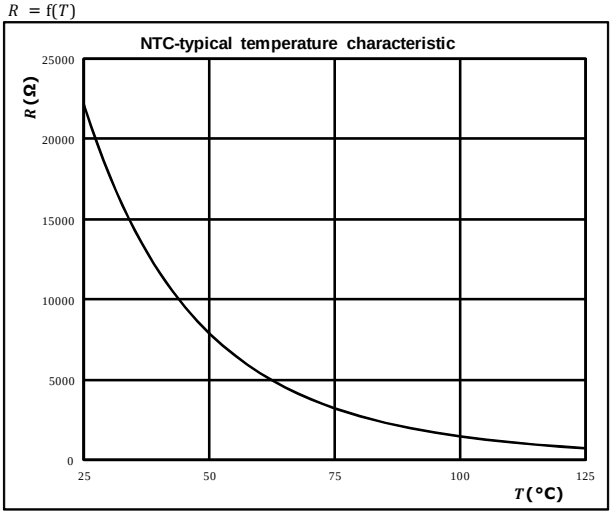
R (K/W)	τ (s)
7,02E-02	3,35E+00
1,23E-01	4,61E-01
4,54E-01	8,36E-02
3,54E-01	2,44E-02
1,81E-01	5,52E-03
7,18E-02	8,18E-04

Thermistor Characteristics

figure 1. **Thermistor**

Typical NTC characteristic
as a function of temperature

$R = f(T)$

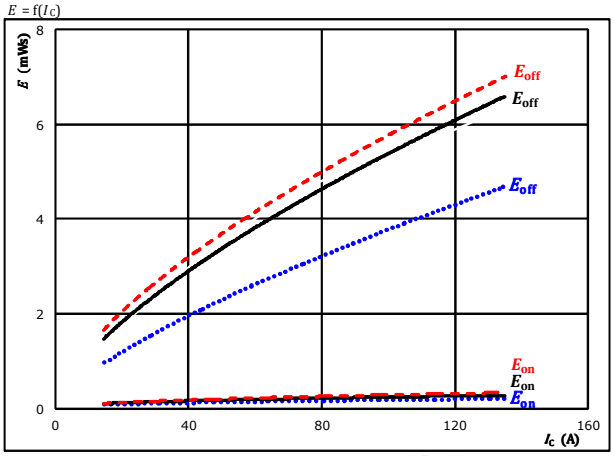


Buck Switching Characteristics

figure 1. IGBT

Typical switching energy losses as a function of collector current

$E = f(I_C)$



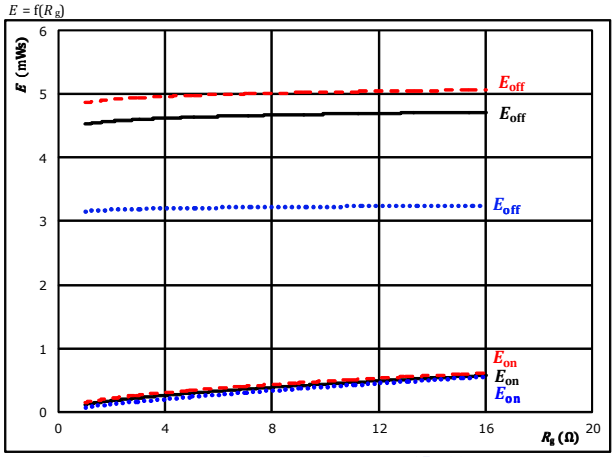
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	±15	V		125 °C	
R_{gon} =	4	Ω		150 °C	
R_{goff} =	4	Ω			

figure 2. IGBT

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



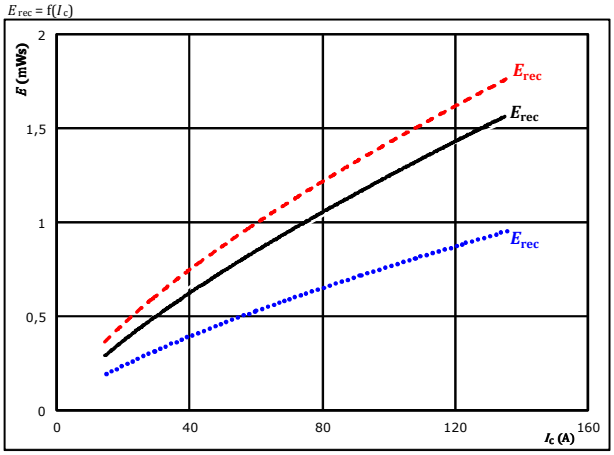
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	±15	V		125 °C	
I_C =	75	A		150 °C	

figure 3. FWD

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



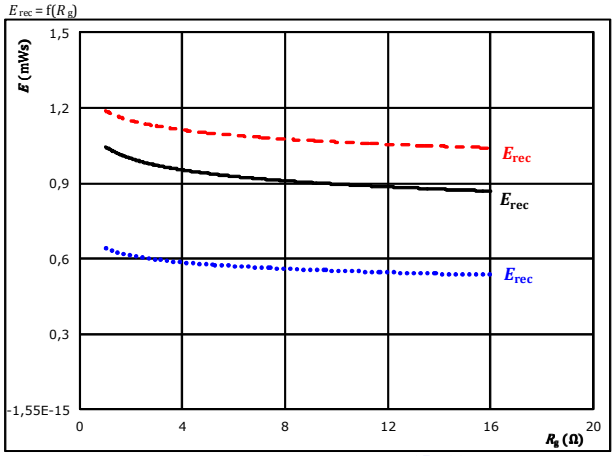
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	±15	V		125 °C	
R_{gon} =	4	Ω		150 °C	

figure 4. FWD

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

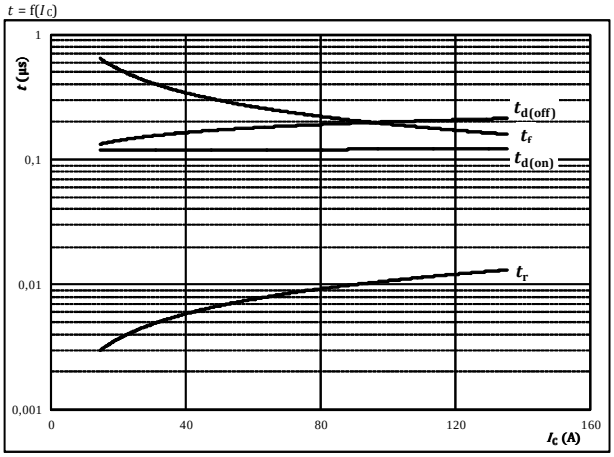
V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	±15	V		125 °C	
I_C =	75	A		150 °C	

Buck Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



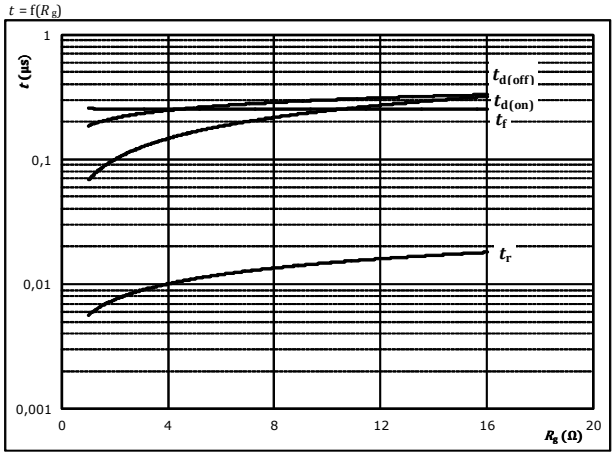
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



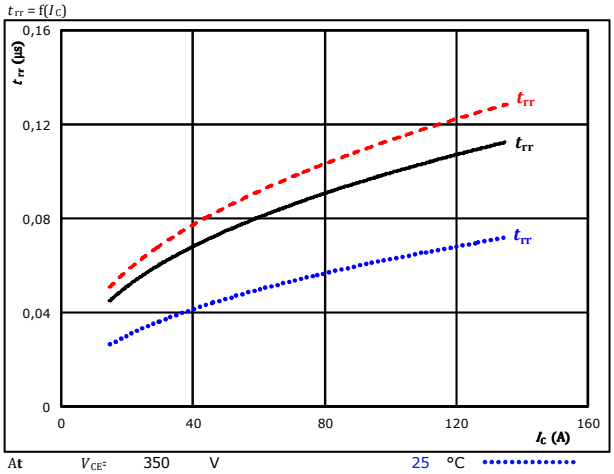
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	75	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

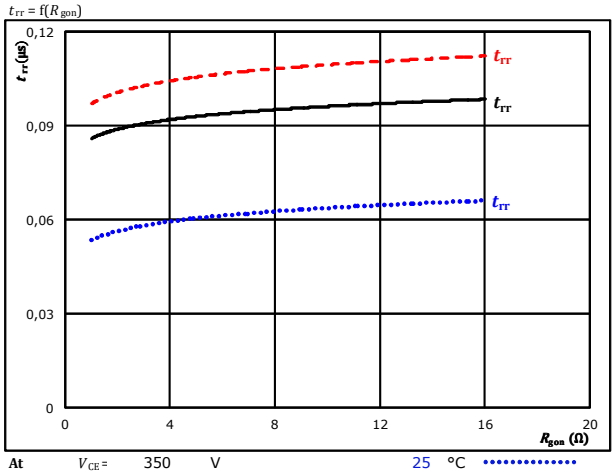


At					
V_{CE} =	350	V	T_j:	25 °C	
V_{GE} =	±15	V		125 °C	
R_{gon} =	4	Ω		150 °C	

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



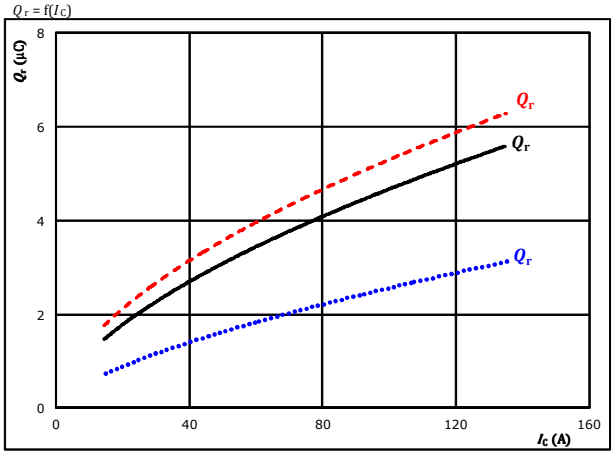
At					
V_{CE} =	350	V	T_j:	25 °C	
V_{GE} =	±15	V		125 °C	
I_C =	75	A		150 °C	

Buck Switching Characteristics

figure 9. **FWD**

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

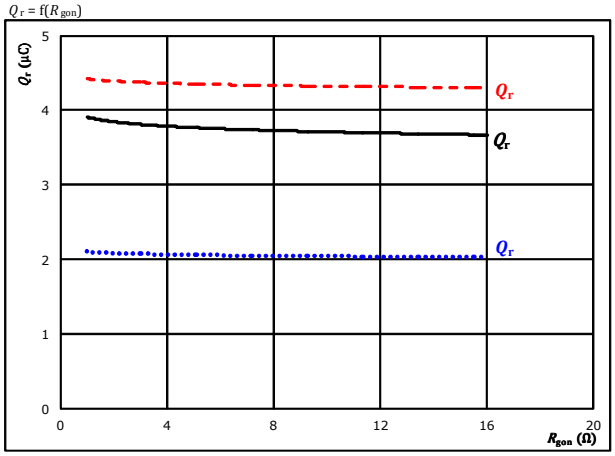


At						
	V_{CE} =	350	V		25 °C	
	V_{GE} =	±15	V	T_j:	125 °C	
	R_{gon} =	4	Ω		150 °C	

figure 10. **FWD**

Typical recoved charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

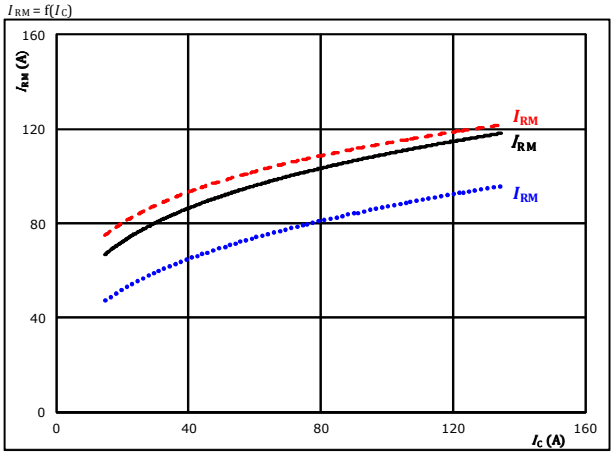


At						
	V_{CE}=	350	V		25 °C	
	V_{GE} =	±15	V	T_j:	125 °C	
	I_C=	75	A		150 °C	

figure 11. **FWD**

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

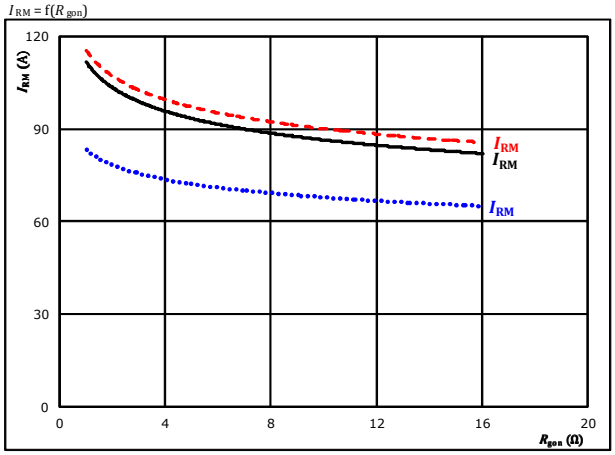


At						
	V_{CE}:	350	V		25 °C	
	V_{GE} =	±15	V	T_j:	125 °C	
	R_{gon} =	4	Ω		150 °C	

figure 12. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



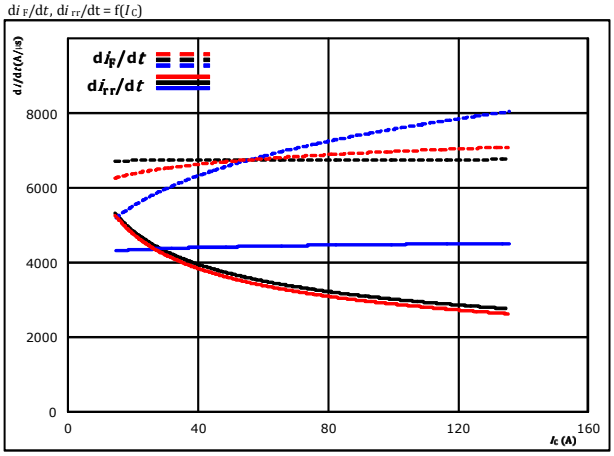
At						
	V_{CE} =	350	V		25 °C	
	V_{GE} =	±15	V	T_j:	125 °C	
	I_C =	75	A		150 °C	

Buck Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$

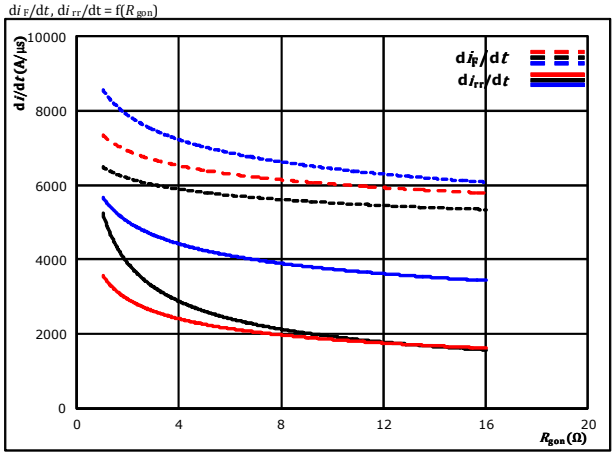


At						
V_{CE} =	350	V	T_j:	25 °C	•••••••••••••••
V_{GE} =	±15	V		125 °C	———
R_{gon} =	4	Ω		150 °C	– – – –

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$

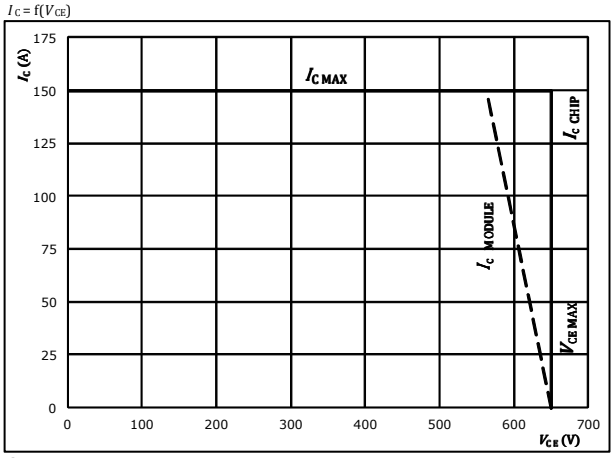


At						
V_{CE} =	350	V	T_j:	25 °C	•••••••••••••••
V_{GE} =	±15	V		125 °C	———
I_C=	75	A		150 °C	– – – –

figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

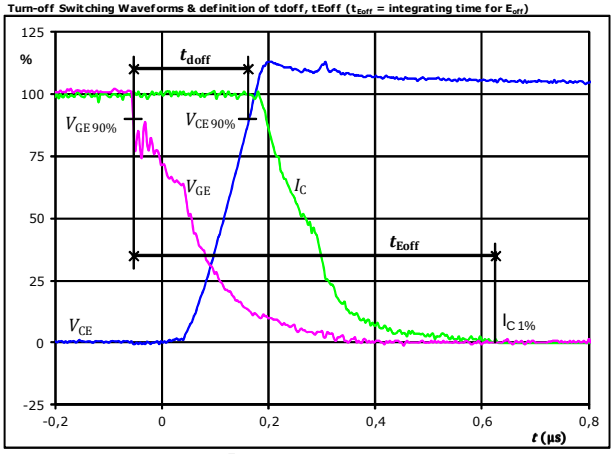
Buck Switching Definitions

General conditions

T_j	=	**125 °C**
R_{gon}	=	**4 Ω**
R_{goff}	=	**4 Ω**

figure 1. IGBT

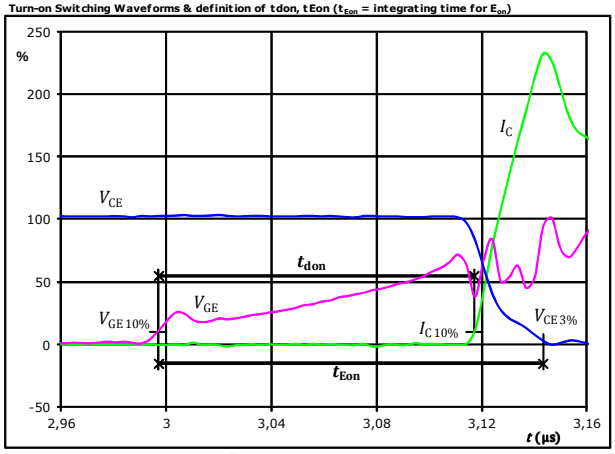
Turn-off Switching Waveforms & definition of tdoff, tEoff (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_{doff} =	0,215	µs
t_{Eoff} =	0,679	µs

figure 2. IGBT

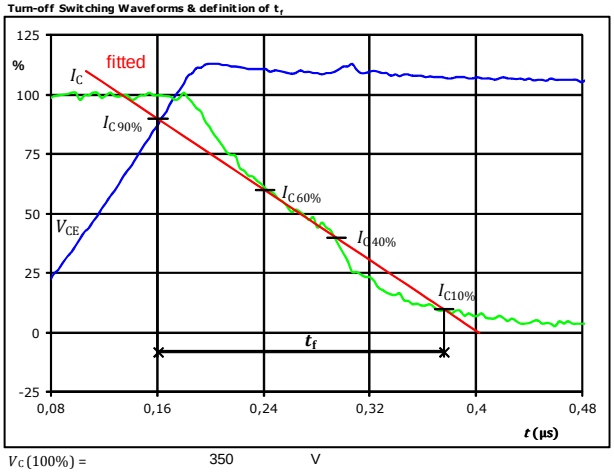
Turn-on Switching Waveforms & definition of tdon, tEon (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_{don} =	0,121	µs
t_{Eon} =	0,146	µs

figure 3. IGBT

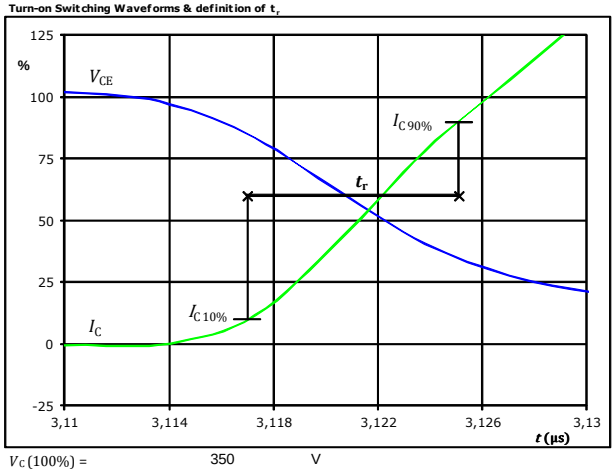
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_f =	0,217	µs

figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r

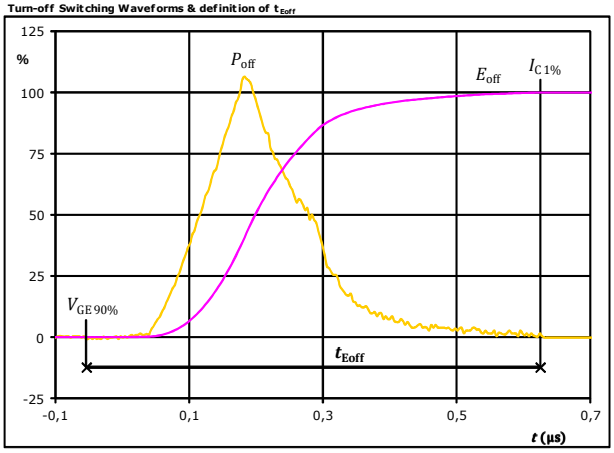


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_r =	0,008	µs

Buck Switching Characteristics

figure 5. **IGBT**

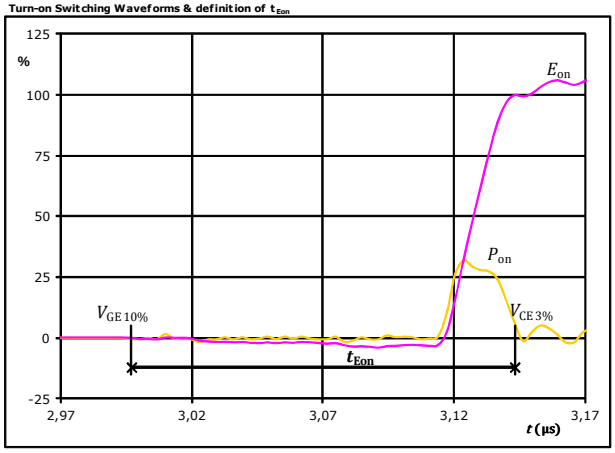
Turn-off Switching Waveforms & definition of t_{Eoff}



$P_{off}(100\%) =$	26,22	kW
$E_{off}(100\%) =$	4,65	mJ
$t_{Eoff} =$	0,68	µs

figure 6. **IGBT**

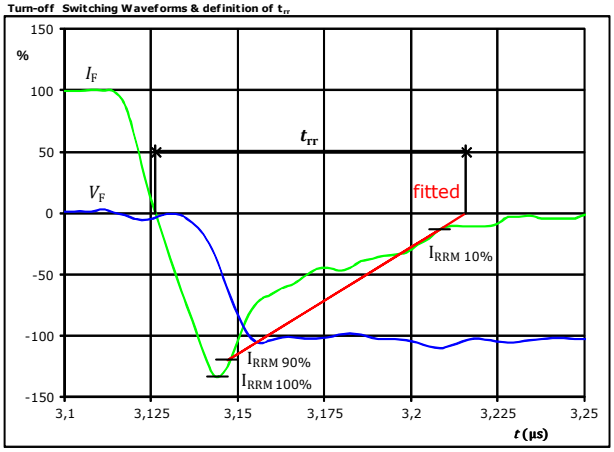
Turn-on Switching Waveforms & definition of t_{Eon}



$P_{on}(100\%) =$	26,22	kW
$E_{on}(100\%) =$	0,16	mJ
$t_{Eon} =$	0,15	µs

figure 7. **FWD**

Turn-off Switching Waveforms & definition of t_{rr}

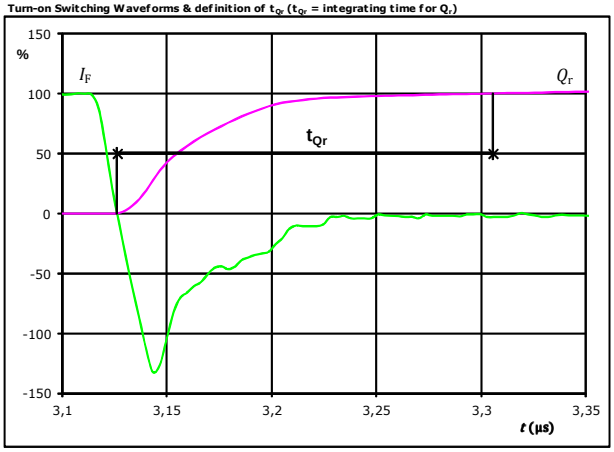


$V_F(100\%) =$	350	V
$I_F(100\%) =$	75	A
$I_{RRM}(100\%) =$	-101	A
$t_{rr} =$	0,089	µs

Buck Switching Characteristics

figure 8. **FWD**

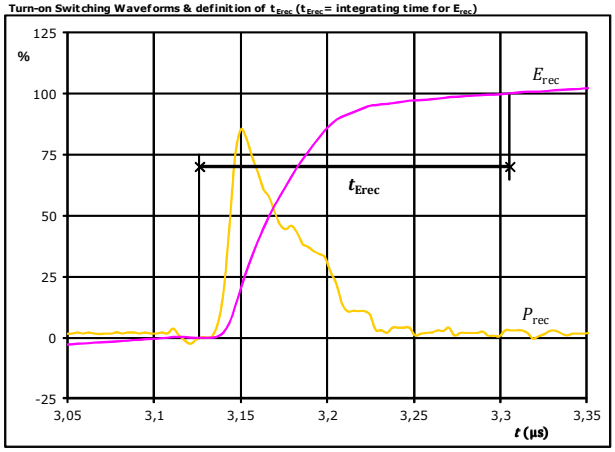
Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



I_F (100%) =	75	A
Q_r (100%) =	3,82	µC
t_{Qr} =	0,18	µs

figure 9. **FWD**

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})



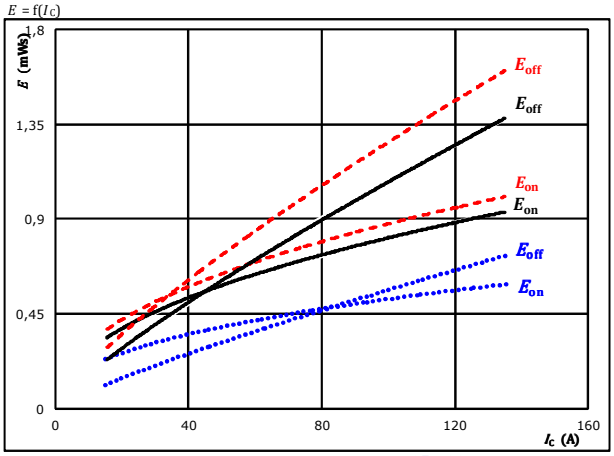
P_{rec} (100%) =	26,22	kW
E_{rec} (100%) =	0,99	mJ
t_{Erec} =	0,18	µs

Boost Switching Characteristics

figure 1. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



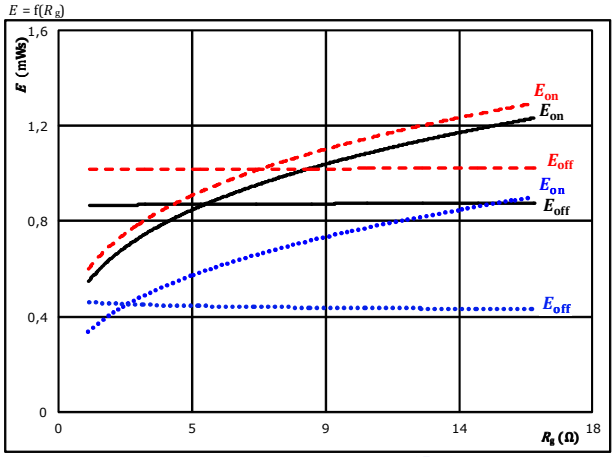
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C
V_{GE} =	-5/15	V		125 °C
R_{gon} =	4	Ω		150 °C
R_{goff} =	4	Ω		

figure 2. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



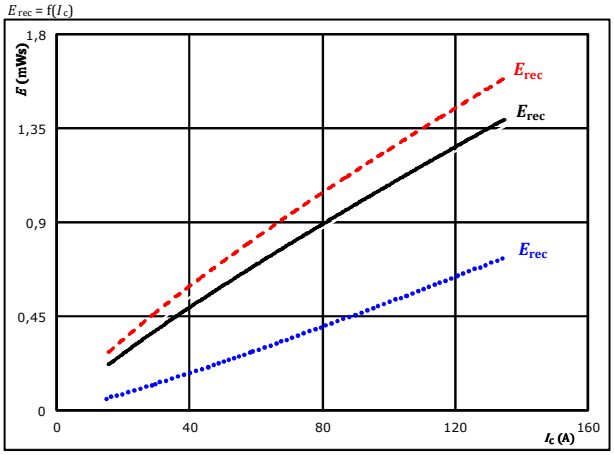
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C
V_{GE} =	-5/15	V		125 °C
I_C =	76	A		150 °C

figure 3. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



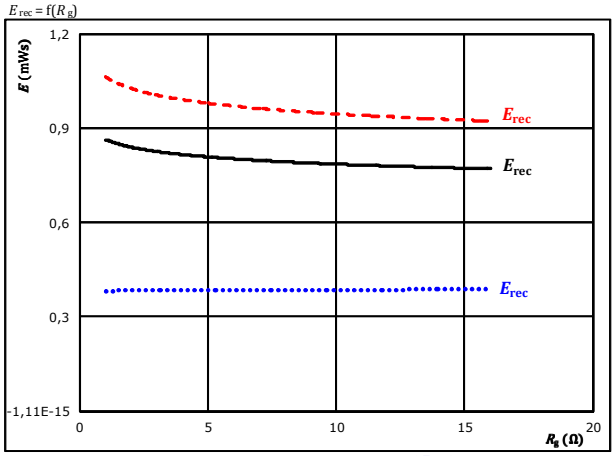
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C
V_{GE} =	-5/15	V		125 °C
R_{gon} =	4	Ω		150 °C

figure 4. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

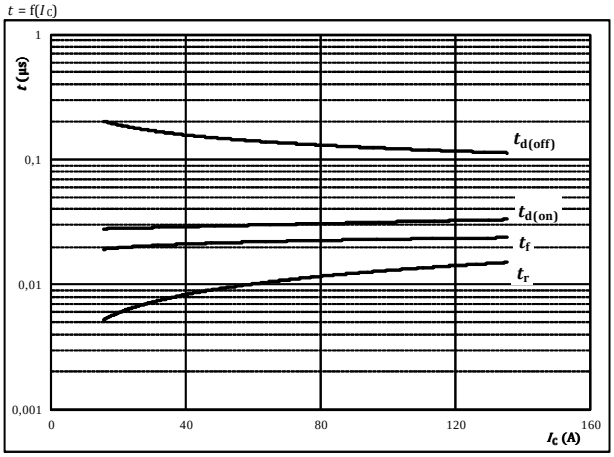
V_{CE} =	350	V	T_J:	25 °C
V_{GE} =	-5/15	V		125 °C
I_C =	76	A		150 °C

Boost Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



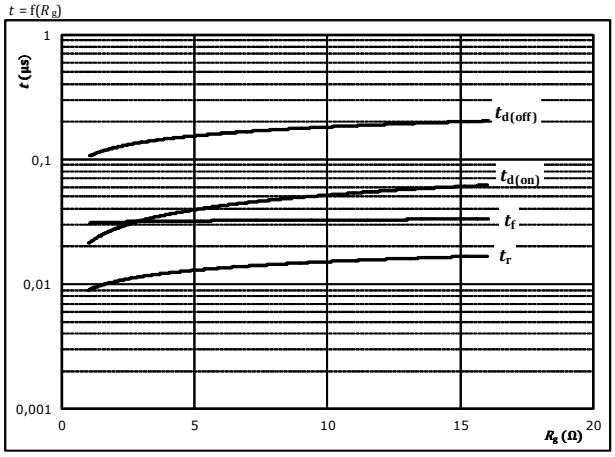
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	-5/15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



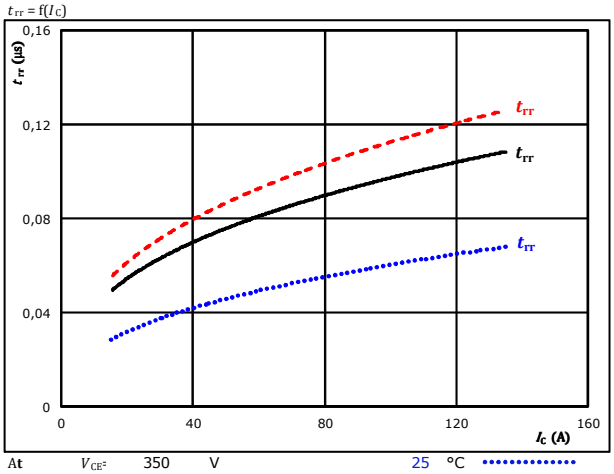
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	-5/15	V
I_C =	76	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



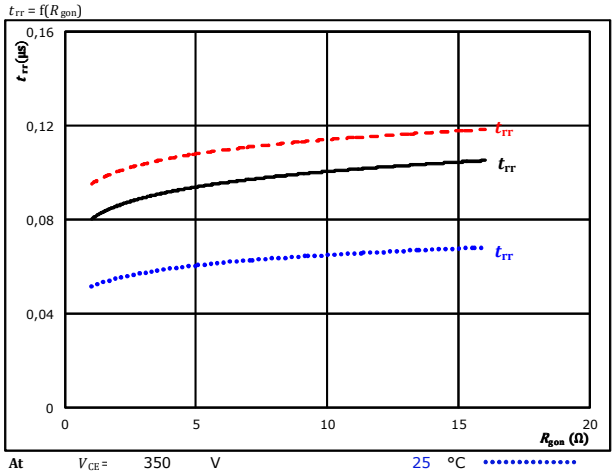
At

V_{CE} =	350	V	T_j:	25 °C	·····
V_{GE} =	-5/15	V		125 °C	———
R_{gon} =	4	Ω		150 °C	– – –

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



At

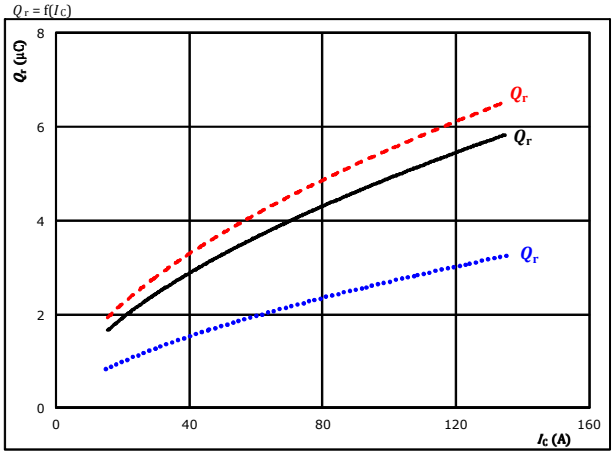
V_{CE} =	350	V	T_j:	25 °C	·····
V_{GE} =	-5/15	V		125 °C	———
I_C =	76	A		150 °C	– – –

Boost Switching Characteristics

figure 9. **FWD**

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

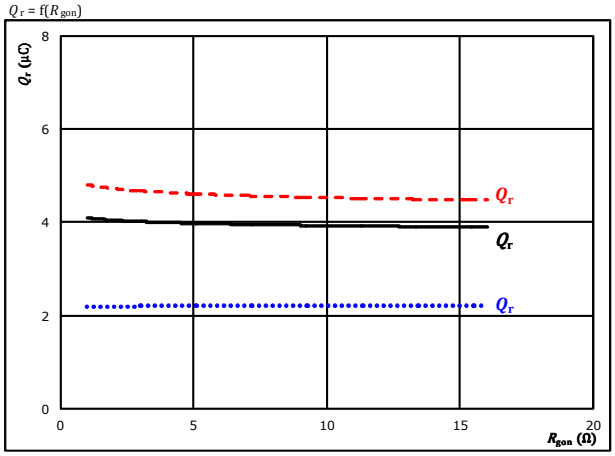


At						
	V_{CE} =	350	V		25 °C	
	V_{GE} =	-5/15	V	T_j:	125 °C	
	R_{gon} =	4	Ω		150 °C	

figure 10. **FWD**

Typical recoved charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

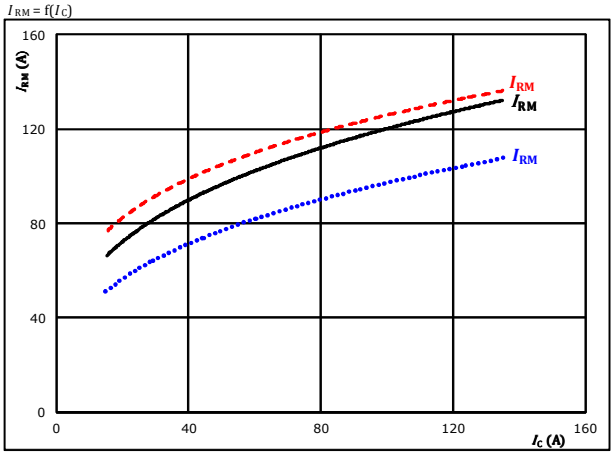


At						
	V_{CE}=	350	V		25 °C	
	V_{GE} =	-5/15	V	T_j:	125 °C	
	I_C=	76	A		150 °C	

figure 11. **FWD**

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

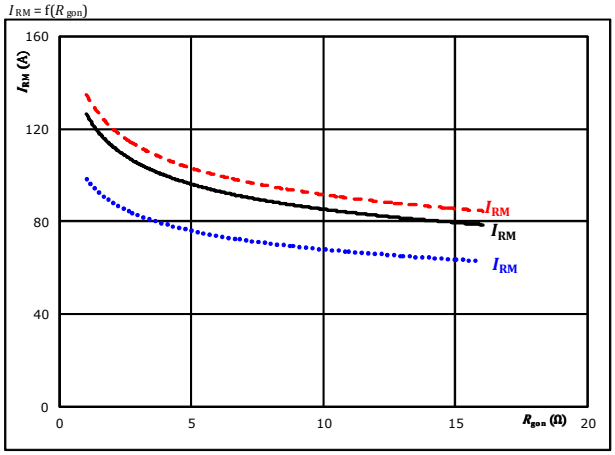


At						
	V_{CE}:	350	V		25 °C	
	V_{GE} =	-5/15	V	T_j:	125 °C	
	R_{gon} =	4	Ω		150 °C	

figure 12. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



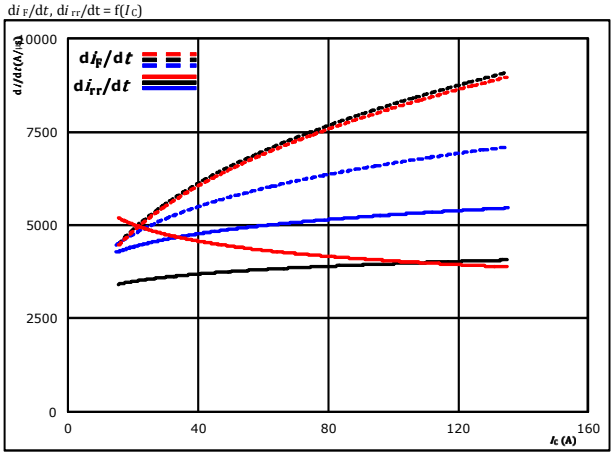
At						
	V_{CE} =	350	V		25 °C	
	V_{GE} =	-5/15	V	T_j:	125 °C	
	I_C =	76	A		150 °C	

Boost Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$

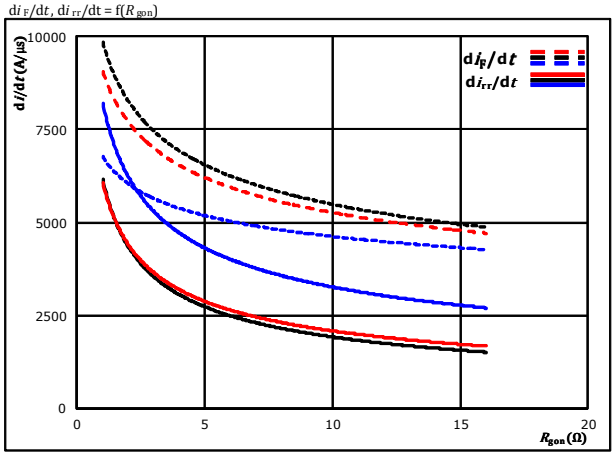


At						
V_{CE} =	350	V	T_j:	25 °C	•••••••••••••••
V_{GE} =	-5/15	V		125 °C	———
R_{gon} =	4	Ω		150 °C	– – – –

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$

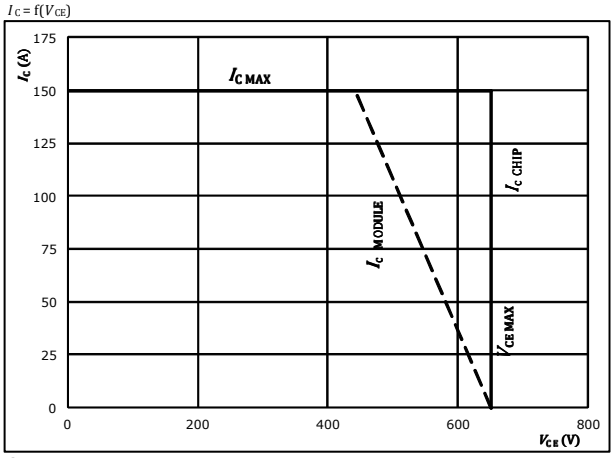


At						
V_{CE} =	350	V	T_j:	25 °C	•••••••••••••••
V_{GE} =	-5/15	V		125 °C	———
I_C =	76	A		150 °C	– – – –

figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

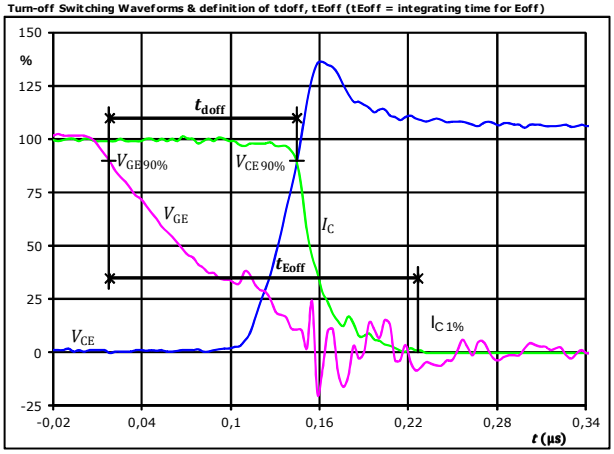
Boost Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

figure 1. IGBT

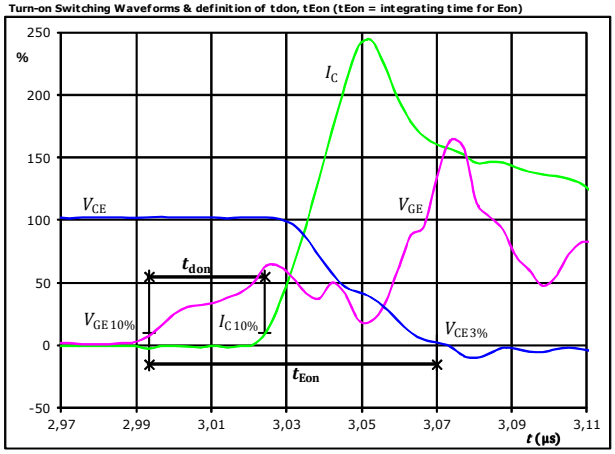
Turn-off Switching Waveforms & definition of tdoff, tEoff (tEoff = integrating time for Eoff)



$V_{GE}(0\%)$ =	-5	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_{doff} =	0,126	µs
t_{Eoff} =	0,208	µs

figure 2. IGBT

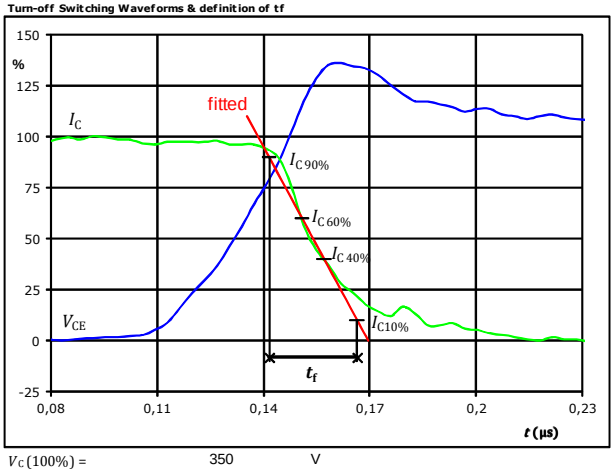
Turn-on Switching Waveforms & definition of tdon, tEon (tEon = integrating time for Eon)



$V_{GE}(0\%)$ =	-5	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_{don} =	0,031	µs
t_{Eon} =	0,077	µs

figure 3. IGBT

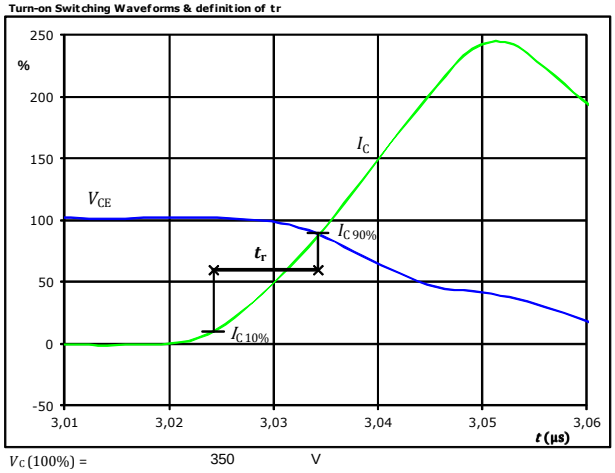
Turn-off Switching Waveforms & definition of tf



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_f =	0,025	µs

figure 4. IGBT

Turn-on Switching Waveforms & definition of tr

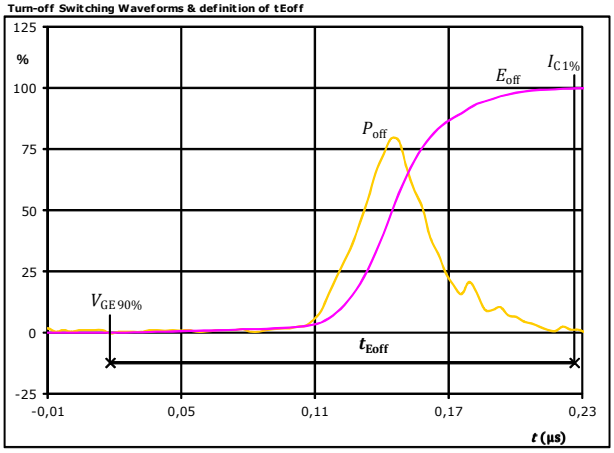


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	76	A
t_r =	0,010	µs

Boost Switching Characteristics

figure 5. **IGBT**

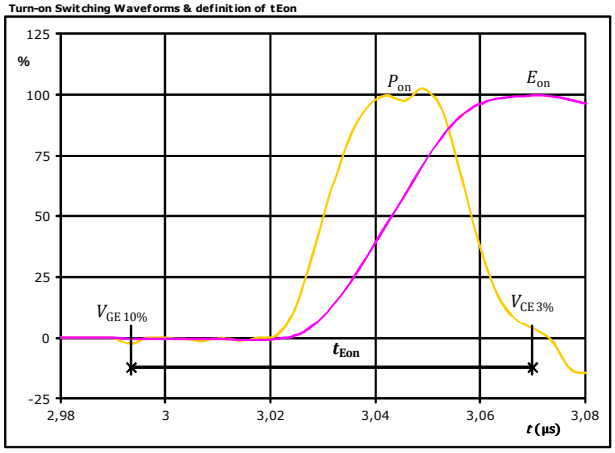
Turn-off Switching Waveforms & definition of tEoff



$P_{off}(100\%)$ =	26,56	kW
$E_{off}(100\%)$ =	0,88	mJ
t_{Eoff} =	0,21	µs

figure 6. **IGBT**

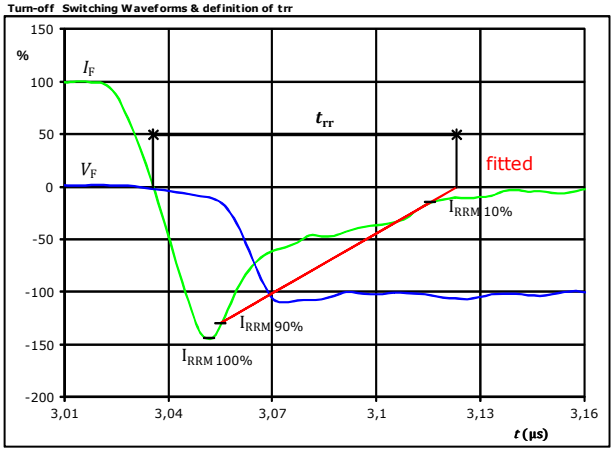
Turn-on Switching Waveforms & definition of tEon



$P_{on}(100\%)$ =	26,56	kW
$E_{on}(100\%)$ =	0,70	mJ
t_{Eon} =	0,08	µs

figure 7. **FWD**

Turn-off Switching Waveforms & definition of trr

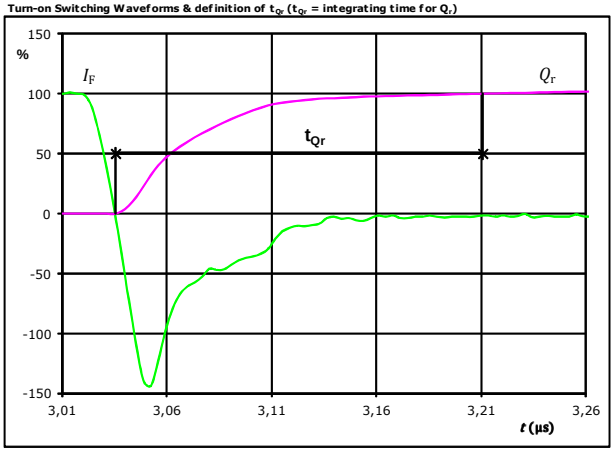


$V_F(100\%)$ =	350	V
$I_F(100\%)$ =	76	A
$I_{RRM}(100\%)$ =	-110	A
t_{rr} =	0,087	µs

Boost Switching Characteristics

figure 8. **FWD**

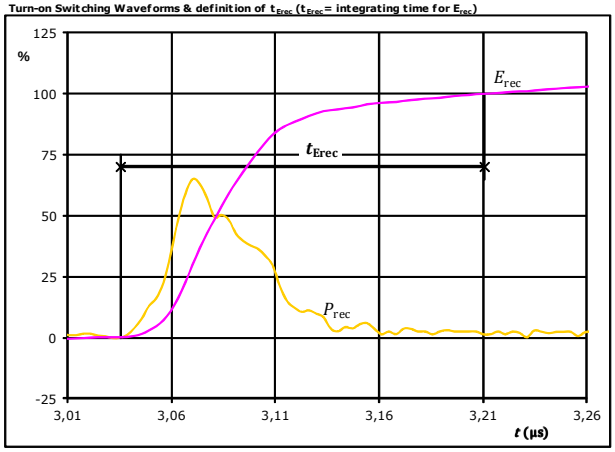
Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



I_F (100%) =	76	A
Q_r (100%) =	4,04	µC
t_{Qr} =	0,18	µs

figure 9. **FWD**

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})



P_{rec} (100%) =	26,56	kW
E_{rec} (100%) =	0,84	mJ
t_{Erec} =	0,18	µs

Vincotech

10-FY07HVA075S5-L985F08
10-PY07HVA075S5-L985F08Y
datasheet

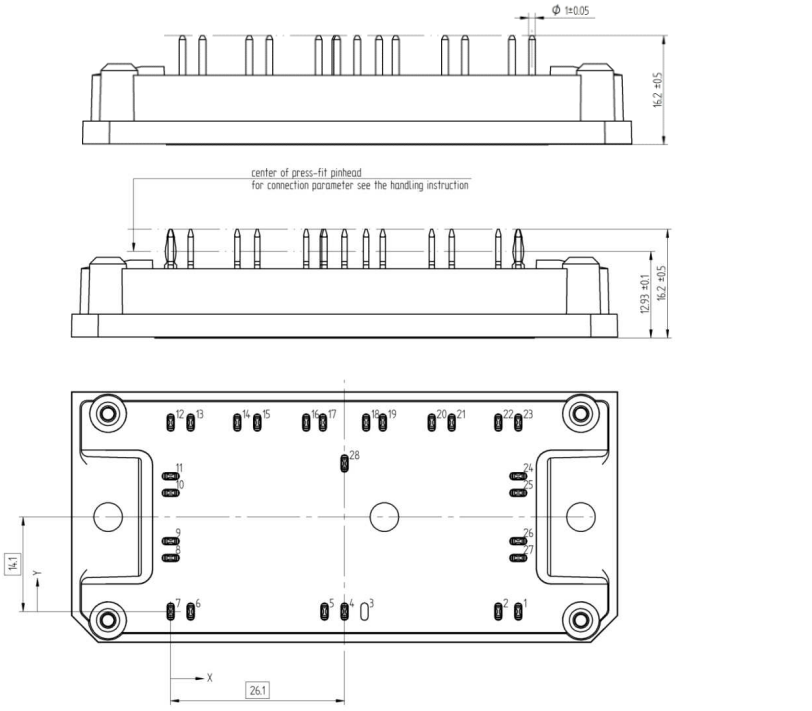
Ordering Code & Marking

Version	Ordering Code
without thermal paste with solder pin 12 mm housing	10-FY07HVA075S5-L985F08
without thermal paste with press-fit 12 mm housing	10-PY07HVA075S5-L985F08Y

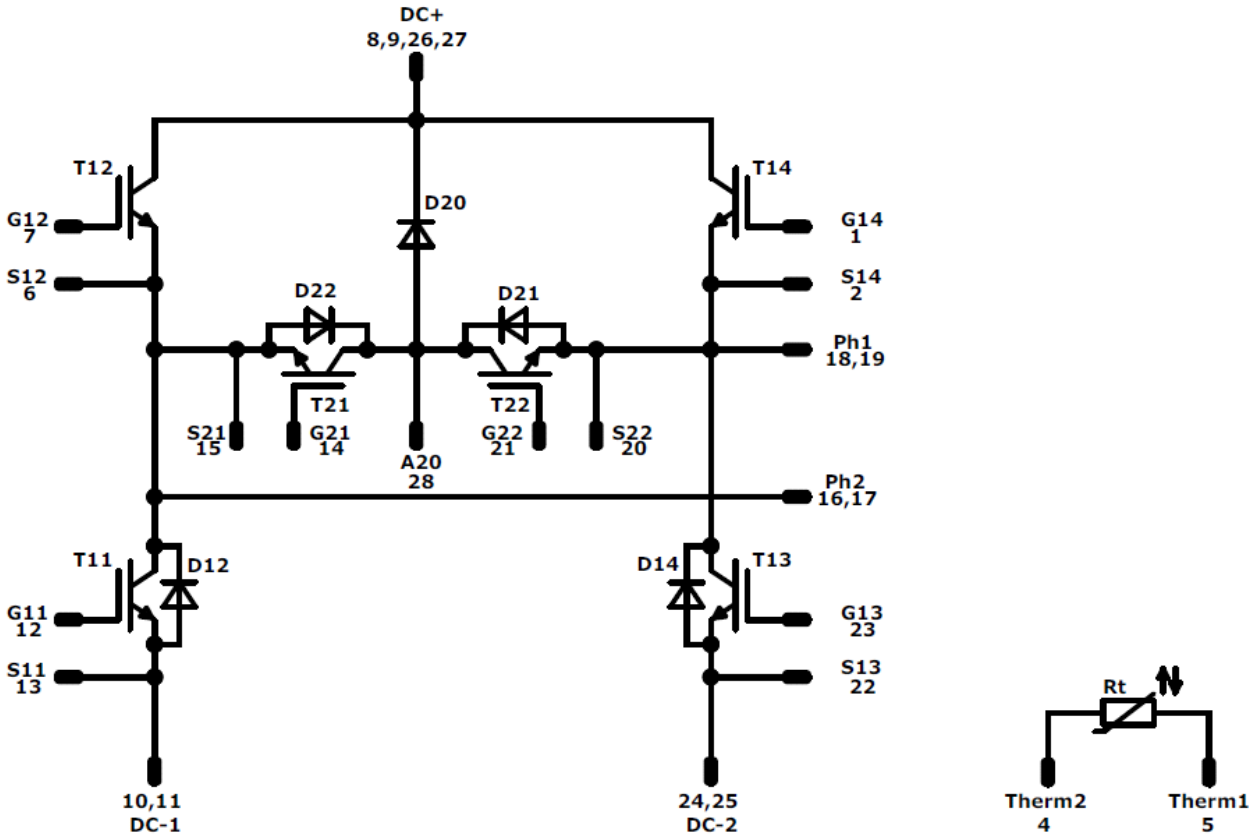
		Name		Date code	UL & VIN	Lot	Serial
Text		NN-NNNNNNNNNNNNN-TTTTTTVV		WWYY	UL VIN	LLLLL	SSSS
		Type&Ver	**Lot number**	**Serial**	**Date code**		
Datamatrix		TTTTTTTVV	LLLLL	SSSS	WWYY		

Outline

Pin table			
Pin	X	Y	Function
1	52,2	0	G14
2	49,2	0	S14
3	Not assembled		
4	26,1	0	Therm2
5	23,1	0	Therm1
6	3	0	S12
7	0	0	G12
8	0	8	DC+
9	0	10,5	DC+
10	0	17,7	DC-1
11	0	20,2	DC-1
12	0	28,2	G11
13	3	28,2	S11
14	10	28,2	G21
15	13	28,2	S21
16	20,35	28,2	Ph2
17	22,85	28,2	Ph2
18	29,35	28,2	Ph1
19	31,85	28,2	Ph1
20	39,2	28,2	S22
21	42,2	28,2	G22
22	49,2	28,2	S13
23	52,2	28,2	G13
24	52,2	20,2	DC-2
25	52,2	17,7	DC-2
26	52,2	10,5	DC+
27	52,2	8	DC+
28	26,1	22,1	A20



Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T11 , T12 , T13, T14	IGBT	650 V	75 A	High Buck Switch / Low Buck Switch	
D21, D22	FWD	650 V	50 A	Buck Diode	
T21, T22	IGBT	650 V	75 A	Boost Switch	
D12, D14, D20	FWD	650 V	50 A	Low Boost Diode / High Boost Diode	
Rt	NTC			Thermistor	

Packaging instruction				
Standard packaging quantity (SPQ) 100	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 1 packages see vincotech.com website.

Package data
Package data for *flow* 1 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
10-xY07HVA075S5-L985F08x-D1-14	02 Aug. 2017		